INTEGRATED CIRCUITS

DATA SHEET

74ABT162240

16-bit inverting buffer/driver with 30Ω series termination resistors

Product data Supersedes data of 1998 Feb 25

2004 Feb 18





16-bit inverting buffer/driver with 30 Ω series termination resistors (3-State)

74ABT162240

FEATURES

- 16-bit bus interface
- 3-State buffers
- Output capability: +12mA/-32mA
- TTL input and output switching levels
- Live insertion/extraction permitted
- Power-up 3-State
- Latch-up protection exceeds 500mA per JEDEC Std 17
- ESD protection exceeds 2000V per MIL STD 883 Method 3015 and 200V per Machine Model

DESCRIPTION

The 74ABT162240 is a high-performance BiCMOS device which combines low static and dynamic power dissipation with high speed.

This device is an inverting 16-bit buffer that is ideal for driving bus lines. The device features four Output Enables ($1\overline{OE}$, $2\overline{OE}$, $3\overline{OE}$, $4\overline{OE}$), each controlling four of the 3-State outputs.

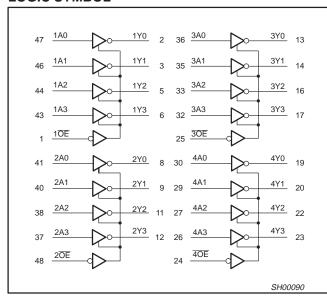
QUICK REFERENCE DATA

SYMBOL	PARAMETER	CONDITIONS T _{amb} = 25°C	TYPICAL	UNIT
t _{PLH} t _{PHL}	Propagation delay nAx to n\overline{Y}x	$C_L = 50pF;$ $V_{CC} =$	2.7 2.6	ns
C _{IN}	Input capacitance nOE	$V_I = 0V \text{ or } 3.0V$	4	pF
C _{OUT}	Output capacitance	Outputs disabled; $V_O = 0V$ or	6	pF
I _{CCZ}	Quiescent supply current	Outputs disabled; V _{CC} =	500	μΑ
I _{CCL}	Quicocont supply current	Outputs low; V _{CC} = 5.5V	8	mA

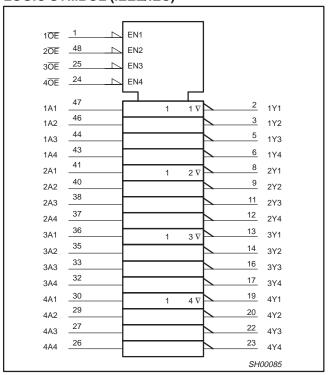
ORDERING INFORMATION

PACKAGES	TEMPERATURE RANGE	TYPE NUMBER	DWG NUMBER
48-Pin Plastic SSOP Type III	−40°C to +85°C	74ABT162240 DL	SOT370-1
48-Pin Plastic TSSOP Type II	-40°C to +85°C	74ABT162240 DGG	SOT362-1

LOGIC SYMBOL



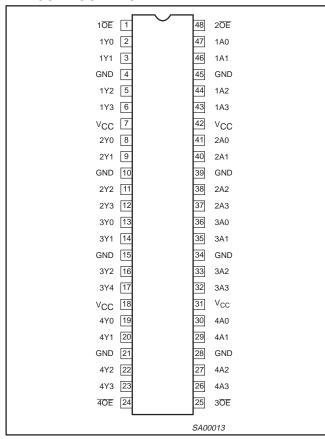
LOGIC SYMBOL (IEEE/IEC)



16-bit inverting buffer/driver with 30Ω series termination resistors (3-State)

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PIN CONFIGURATION



FUNCTION TABLE

Inp	uts	Outputs			
nŌĒ	nAx	n₹x			
L	L	Н			
L	Н	L			
Н	Х	Z			

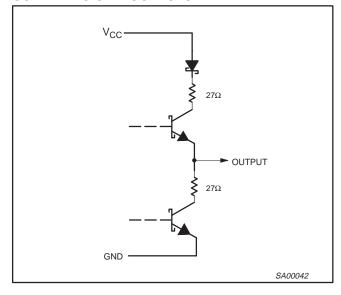
H = High voltage level

L = Low voltage level

X = Don't care

Z = High Impedance "off" state

SCHEMATIC OF Y OUTPUTS



PIN DESCRIPTION

PIN NUMBER	SYMBOL	NAME AND FUNCTION
47, 46, 44, 43, 41, 40, 38, 37, 36, 35, 33, 32, 30, 29, 27, 26	1A0-1A3 2A0-2A3 3A0-3A3 4A0-4A3	Data inputs
2, 3, 5, 6, 8, 9, 11, 12, 13, 14, 16, 17, 19, 20, 22, 23	1\(\bar{9}\) -1\(\bar{9}\) 3\(\bar{9}\) -2\(\bar{9}\) 3\(\bar{9}\) -3\(\bar{9}\) 4\(\bar{9}\) -4\(\bar{9}\) 3	Data outputs
1, 48, 25, 24	1 <u>0E</u> , 2 <u>0E</u> , 3 <u>0E</u> , 4 <u>0E</u>	Output enables
4, 10, 15, 21, 28, 34, 39, 45	GND	Ground (0V)
7, 18, 31, 42	V _{CC}	Positive supply voltage

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ABSOLUTE MAXIMUM RATINGS^{1, 2}

SYMBOL	PARAMETER	CONDITIONS	RATING	UNIT
V _{CC}	DC supply voltage		-0.5 to +7.0	V
I _{IK}	DC input diode current	V _I < 0	-18	mA
VI	DC input voltage ³		-1.2 to +7.0	V
I _{OK}	DC output diode current	V _O < 0	– 50	mA
V _{OUT}	DC output voltage ³	Output in Off or High state	-0.5 to +5.5	V
la	DC output current	Output in Low state	128	mA
IOUT	DC output current	Output in High state	-64] "''^
T _{stg}	Storage temperature range		-65 to +150	°C

NOTES:

RECOMMENDED OPERATING CONDITIONS

CVMDOL	DADAMETED	LIM		
SYMBOL	PARAMETER	MIN	MAX	UNIT
V _{CC}	DC supply voltage	4.5	5.5	V
VI	Input voltage	0	V _{CC}	V
V _{IH}	High-level input voltage	2.0		V
V_{IL}	Input voltage		0.8	V
I _{OH}	High-level output current		-32	mA
I _{OL}	Low-level output current		32	mA
	Low-level output current; current duty cycle ≤ 50%; f ≥ 1kHz		12	1
Δt/Δν	Input transition rise or fall rate; Outputs enabled	0	10	ns/V
T _{amb}	Operating free-air temperature range	-40	+85	°C

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Stresses beyond those listed may cause permanent damage to the device. These are stress ratings only and functional operation of the
device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to
absolute-maximum-rated conditions for extended periods may affect device reliability.

The performance capability of a high-performance integrated circuit in conjunction with its thermal environment can create junction temperatures which are detrimental to reliability. The maximum junction temperature of this integrated circuit should not exceed 150°C.

^{3.} The input and output negative voltage ratings may be exceeded if the input and output clamp current ratings are observed.

16-bit inverting buffer/driver with 30Ω series termination resistors (3-State)

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DC ELECTRICAL CHARACTERISTICS

					LIMITS			UNIT
SYMBOL	PARAMETER	TEST CONDITIONS	Ta	_{mb} = +25	5°C	T _{amb} =	-40°C 85°C	
			Min Typ Max		Min	Max		
V _{IK}	Input clamp voltage	$V_{CC} = 4.5V; I_{IK} = -18mA$		-0.9	-1.2		-1.2	V
		$V_{CC} = 4.5V$; $I_{OH} = -3mA$; $V_I = V_{IL}$ or V_{IH}	2.5	2.9		2.5		V
V _{OH}	High-level output voltage	$V_{CC} = 5.0V$; $I_{OH} = -3mA$; $V_I = V_{IL}$ or V_{IH}	3.0	3.4		3.0		V
		$V_{CC} = 4.5V$; $I_{OH} = -32mA$; $V_I = V_{IL}$ or V_{IH}	2.0	2.4		2.0		V
Vol	Low-level output voltage	$V_{CC} = 4.5V$; $I_{OL} = 8mA$; $V_I = V_{IL}$ or V_{IH}			0.65		0.65	V
VOL	Low-level output voltage	$V_{CC} = 4.5V$; $I_{OL} = 12mA$; $V_I = V_{IL}$ or V_{IH}			0.80		0.80	V
lı	Input leakage current	V _{CC} = 5.5V; V _I = GND or 5.5V		±0.01	±1.0		±1.0	μΑ
I _{OFF}	Power-off leakage current	$V_{CC} = 0.0V; V_{O} \text{ or } V_{I} \le 4.5V$		±5.0	±100		±100	μΑ
I _{PU} /I _{PD}	Power-up/down 3-State output current	$V_{\underline{CC}} = 2.0V$; $V_{O} = 0.5V$; $V_{I} = GND$ or V_{CC} ; $V_{OE} = V_{CC}$		±5.0	±50		±50	μΑ
I _{OZH}	3-State output High current	$V_{CC} = 5.5V; V_{O} = 2.7V; V_{I} = V_{IL} \text{ or } V_{IH}$		1.0	10		10	μΑ
I _{OZL}	3-State output Low current	$V_{CC} = 5.5V; V_{O} = 0.5V; V_{I} = V_{IL} \text{ or } V_{IH}$		-1.0	-10		-10	μΑ
I _{CEX}	Output high leakage current	$V_{CC} = 5.5V$; $V_{O} = 5.5V$; $V_{I} = GND$ or V_{CC}		1.0	50		50	μΑ
I _O	Output current ¹	$V_{CC} = 5.5V; V_{O} = 2.5V$	-50	-70	-180	-50	-180	mA
Іссн		$V_{CC} = 5.5V$; Outputs High, $V_I = GND$ or V_{CC}		0.5	1.0		1.0	mA
I _{CCL}	Quiescent supply current	$V_{CC} = 5.5V$; Outputs Low, $V_I = GND$ or V_{CC}		8	19		19	mA
lccz		V_{CC} = 5.5V; Outputs 3-State; V_I = GND or V_{CC}		0.5	1.0		1.0	mA
Δl _{CC}	Additional supply current per input pin ²	Outputs enabled, one input at 3.4V, other inputs at V_{CC} or GND; V_{CC} = 5.5V		10	200		200	μΑ

NOTES:

- 1. Not more than one output should be tested at a time, and the duration of the test should not exceed one second.
- 2. This is the increase in supply current for each input at 3.4V.

AC CHARACTERISTICS

GND = 0V; $t_R = t_F = 2.5 ns$; $C_L = 50 pF$; $R_L = 500 \Omega$; $T_{amb} = -40 ^{\circ} C$ to $+85 ^{\circ} C$.

					LIMIT	rs		
SYMBOL	PARAMETER	WAVEFORM	T _a	_{amb} = +25° 'CC = +5.0'	C V	T _{amb} = -40° V _{CC} = +5.	C to +85°C 0V ±0.5V	UNIT
			Min	Тур	Max	Min	Max	
t _{PLH} t _{PHL}	Propagation delay nAx to nYx	1	1.0 1.0	2.7 2.6	3.8 3.2	1.0 1.0	4.2 3.7	ns
t _{PZH}	Output enable time to High and Low level	2	1.2 1.0	2.3 2.9	3.2 3.8	1.2 1.0	4.0 4.7	ns
t _{PHZ} t _{PLZ}	Output disable time from High and Low level	2	1.6 1.4	3.0 2.8	4.1 3.8	1.6 1.4	4.7 4.0	ns

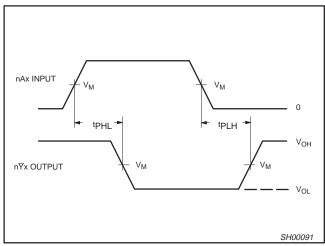
AC WAVEFORMS

 $V_M = 1.5V$, $V_{IN} = GND$ to 2.7V

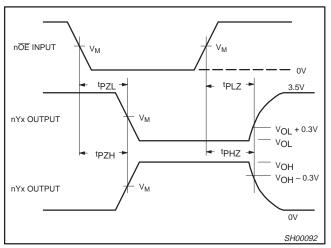
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16-bit inverting buffer/driver with 30Ω series termination resistors (3-State)

74ABT162240

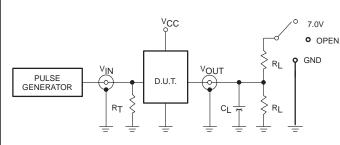


Waveform 1. Input (nAx) to Output (nYx) Propagation Delays



Waveform 2. 3-State Output Enable and Disable Times

TEST CIRCUIT AND WAVEFORMS



Test Circuit for 3-State Outputs

90% NEGATIVE PULSE VM 10% 10% 10% VM 10% VM 10% VM 10% VM 10% VM VM 10W VM 10% VM 10% VM VM 10% VM 0V

V_M = 1.5V Input Pulse Definition

SWITCH POSITION

TEST	SWITCH
t _{PLZ}	closed
t _{PZL}	7V
All other	open

DEFINITIONS

R_L = Load resistor; see AC CHARACTERISTICS for value.

C_L = Load capacitance includes jig and probe capacitance; see AC CHARACTERISTICS for value.

 $R_T = Termination resistance should be equal to <math>Z_{OUT}$ of pulse generators.

FAMILY	IN	PUT PULSE R	EQUIRE	MENTS	
FAMILI	Amplitude	Rep. Rate	t _W	t_{R}	t _F
74ABT16	3.0V	1MHz	500ns	2.5ns	2.5ns

SH00093

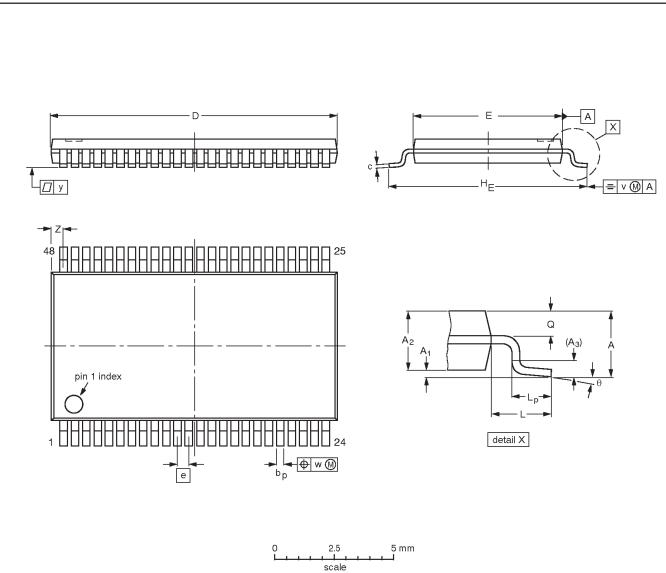
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16-bit inverting buffer/driver with 30Ω series termination resistors (3-State)

74ABT162240

TSSOP48: plastic thin shrink small outline package; 48 leads; body width 6.1 mm

SOT362-1



DIMENSIONS (mm are the original dimensions).

UNIT	A max.	A ₁	A ₂	А3	bp	С	D ⁽¹⁾	E ⁽²⁾	е	HE	L	Lp	Q	٧	w	у	Z	θ
mm	1.2	0.15 0.05	1.05 0.85	0.25	0.28 0.17	0.2 0.1	12.6 12.4	6.2 6.0	0.5	8.3 7.9	1	0.8 0.4	0.50 0.35	0.25	0.08	0.1	0.8 0.4	8° 0°

- 1. Plastic or metal protrusions of 0.15 mm maximum per side are not included.
- 2. Plastic interlead protrusions of 0.25 mm maximum per side are not included.

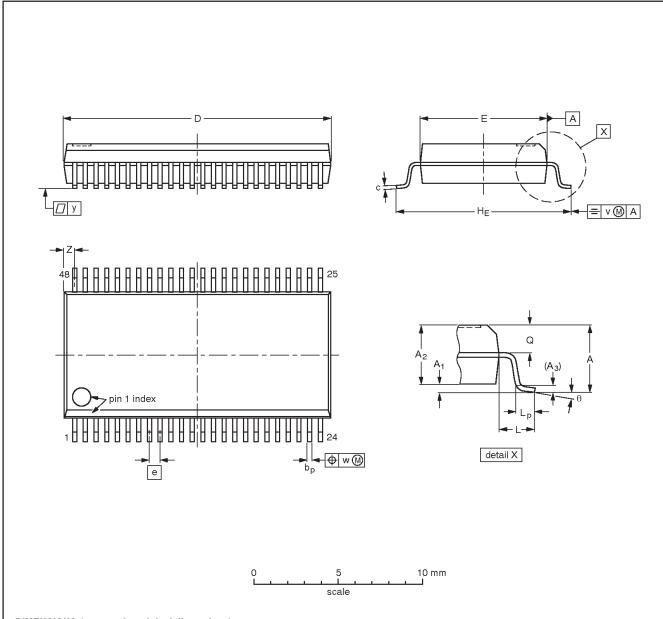
OUTLINE	OUTLINE REFERENCES					ISSUE DATE
VERSION	IEC	JEDEC	JEITA		PROJECTION	ISSUE DATE
SOT362-1		MO-153				99-12-27 03-02-19

16-bit inverting buffer/driver with 30Ω series termination resistors (3-State)

74ABT162240

SSOP48: plastic shrink small outline package; 48 leads; body width 7.5 mm

SOT370-1



DIMENSIONS (mm are the original dimensions)

UNIT	A max.	A ₁	A ₂	A ₃	bp	С	D ⁽¹⁾	E ⁽¹⁾	е	HE	L	Lp	Q	v	w	у	Z ⁽¹⁾	θ
mm	2.8	0.4 0.2	2.35 2.20	0.25	0.3 0.2	0.22 0.13	16.00 15.75	7.6 7.4	0.635	10.4 10.1	1.4	1.0 0.6	1.2 1.0	0.25	0.18	0.1	0.85 0.40	8° 0°

Note

1. Plastic or metal protrusions of 0.25 mm maximum per side are not included.

OUTLINE		REFER	EUROPEAN	ISSUE DATE			
VERSION	IEC	JEDEC	JEITA		PROJECTION	1330E DATE	
SOT370-1		MO-118				99-12-27 03-02-19	

16-bit inverting buffer/driver with 30Ω series termination resistors (3-State)

74ABT162240

REVISION HISTORY

Rev	Date	Description				
_4	20040218	Product data (9397 750 12935); 853-1825 ECN 01-A15419 of 26 January 2004. Supersedes data sheet 74ABT_H162240_3 of 1998 Feb 25 (9397 750 03482).				
		Modifications:				
		Delete all references to 74ABTH162240 (product discontinued).				
_3	19980225	Product data (9397 750 03482); ECN 853-1825 19019 of 25 February 1998. Supersedes previous version.				

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16-bit inverting buffer/driver with 30Ω series termination resistors (3-State)

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Data sheet status

Level	Data sheet status ^[1]	Product status ^{[2] [3]}	Definitions
I	Objective data	Development	This data sheet contains data from the objective specification for product development. Philips Semiconductors reserves the right to change the specification in any manner without notice.
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^[1] Please consult the most recently issued data sheet before initiating or completing a design.

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Limiting values definition — Limiting values given are in accordance with the Absolute Maximum Rating System (IEC 60134). Stress above one or more of the limiting values may cause permanent damage to the device. These are stress ratings only and operation of the device at these or at any other conditions above those given in the Characteristics sections of the specification is not implied. Exposure to limiting values for extended periods may affect device reliability.

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^[3] For data sheets describing multiple type numbers, the highest-level product status determines the data sheet status.